

Magnetic Measurements of APPLE II Type Undulators

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- brief overview of the equipment for magnetic measurements related to insertion devices at BESSY
- experience with the UE56 double undulators
- a new set up for the characterization of block inhomogeneities
- geometrical tolerances
- shimming techniques
- first results of the UE46 APPLE device

Insertion Devices at BESSY II

Permanent Magnet undulators

device	design	operational	$\lambda(mm)$	periods
U49-1	hybrid	1998	49.4	83
U49-2	hybrid	2000	49.4	83
U125-1	hybrid	1998	125	31
U125-2	hybrid QPU	2000	125	31
U41	hybrid	1999	41.2	79
UE56-1	APPLE II	1999	56	2*30
UE56-2	APPLE II	1999	56	2*30
UE46	APPLE II	2001	46	71
UE52	APPLE II	2001	≈ 52	≈ 80
UEnn	APPLE II	2002	$\gg 100$	

Electromagnetic Undulator

device	design	operational	$\lambda(mm)$	periods
U180	planar	1998	180	23

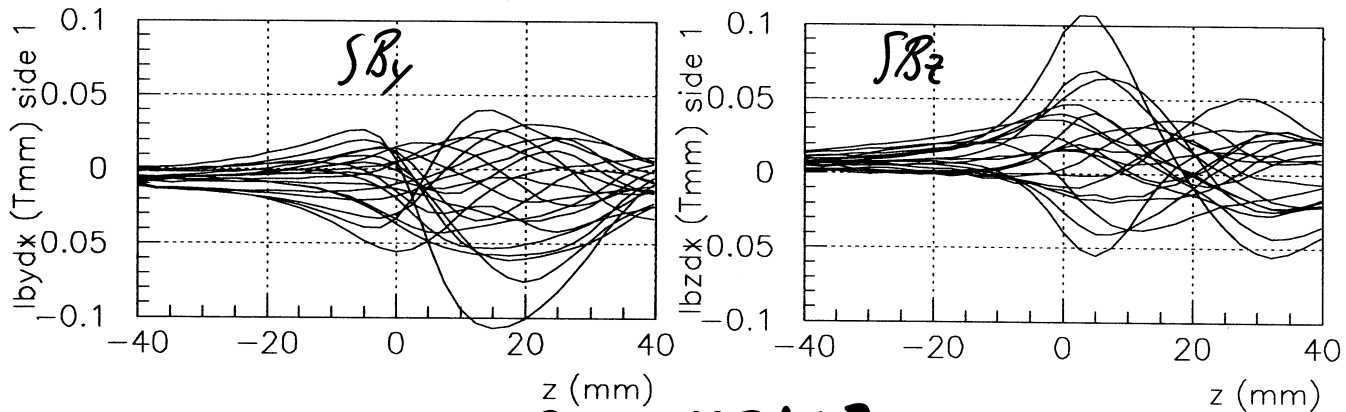
Superconducting WLS and MPW

design	field	operational
WLS	4(6) T	1999(2000)
WLS	7 T	2000
WLS	7 T	2002
MPW	7 T	2002

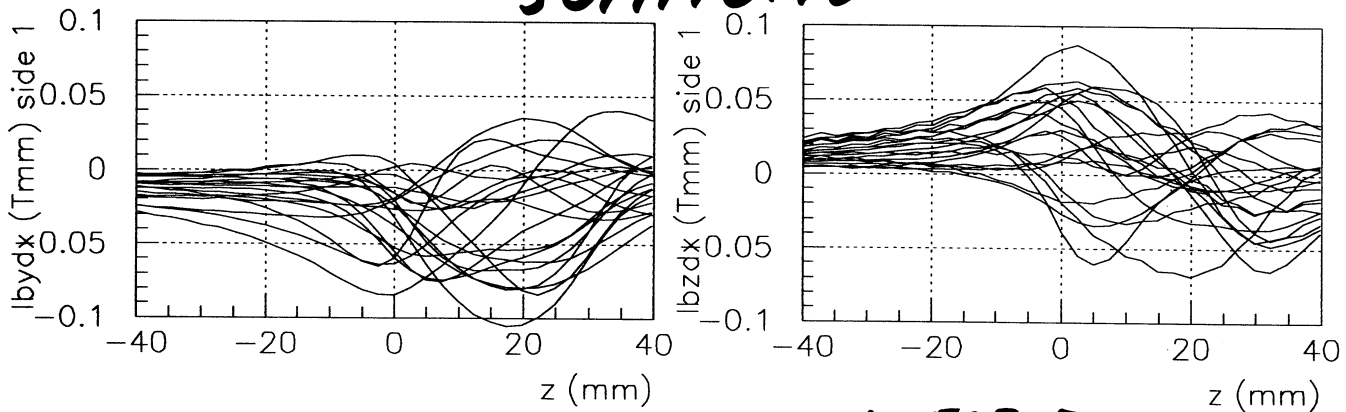
Magnet Blocks from 3 Suppliers

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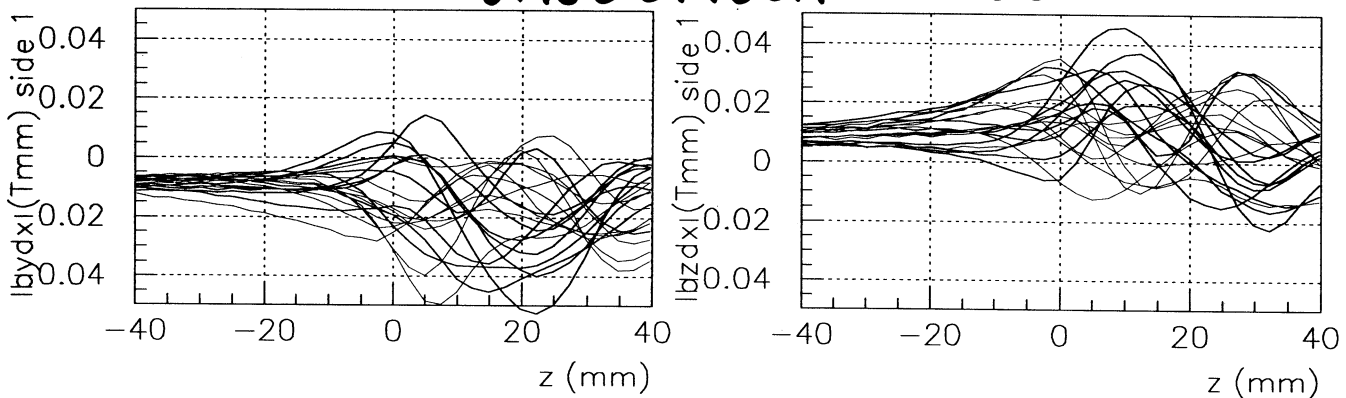
UGIMAG / MAGNEQUENCH



SUMITOMO



VACUUMSCHMELE



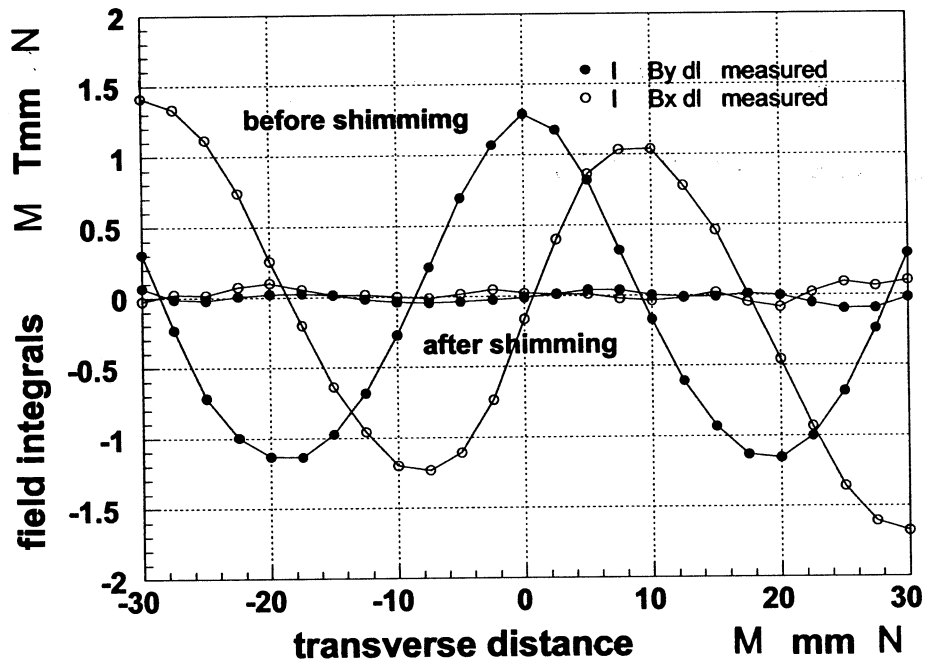
Signal = Σ (Dipole and Inhomogeneities)

Conclusion: i) Inhomogeneities of all suppliers are comparable

ii) Inhomogeneities can not be neglected

Consequences of Systematic Inhomogeneities

UE56 double undulators at BESSY



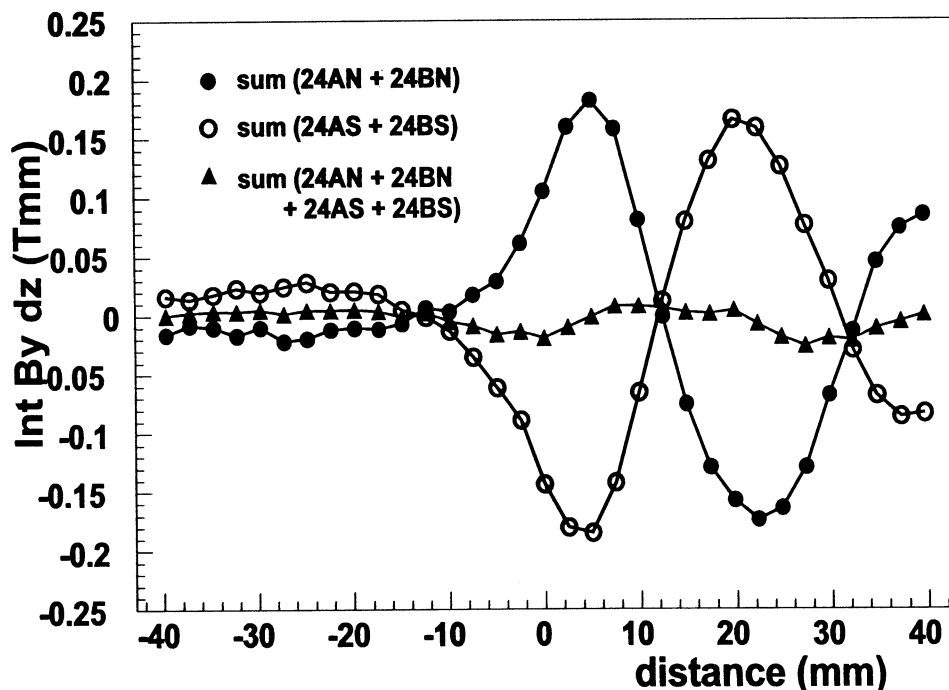
Strategy to solve the problem:

magnetize some magnets parallel and some antiparallel with respect to pressing direction

Concept has been successfully applied to

BESSY UE52

PSI UE56 (in collaboration with BESSY)



Field Optimization Strategy for BESSY Undulators

➤ **Block characterization and sorting**

dipole data from Helmholtz coil (not sufficient for APPLE devices)
inhomogeneity data from mini stretched wire



simulated annealing code



COST function:

- field integrals at 11 transverse location
- phase errors



magnet glueing
and assembling



tight geometrical tolerances



➤ **Shimming**

planar devices:

metal sheets on poles for trajectory shimming
phase errors 2-3° without phase shimming

helical devices (APPLE type):

UE56 double undulators:

permanent magnet shims (0.5x7x14)

to compensate for large systematic inhomogeneities

UE46, UE52, UE56-PSI:

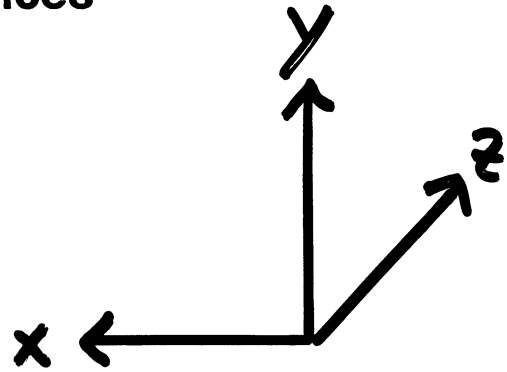
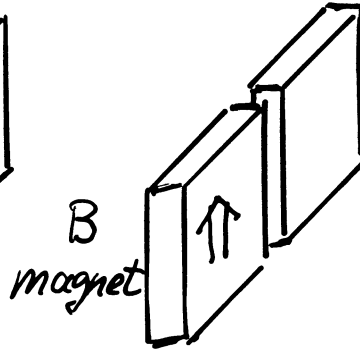
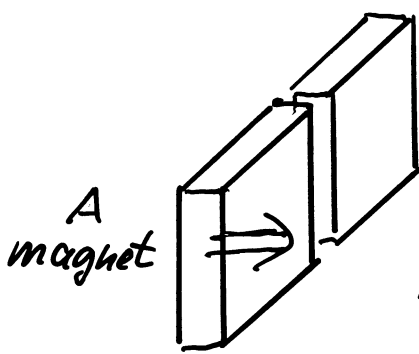
virtual shimming for trajectory and phase optimization

use of lamellated spacers for hor. and vert. adjustment (25µm)

magic fingers at ID-ends for multipole shimming

4mm grid for shim magnets

Geometrical Tolerances



magnet type	operation	max. field integral variation (RADIA)	rms-error achieved (UE46) ⁴⁾	field error scaled to 70 periods ³⁾
A-magnet	↻ x	0	0.073°	0
	↻ y	0.012 Tmm / 0.2°	0.073°	0.10 Tmm
	↻ z	0.015 Tmm / 0.2°	0.073°	0.13 Tmm
	→ z	0	30 μm 1)	0
	→ y	0	20 μm 2)	0
B-magnet	↻ x	0.015 Tmm / 0.02°	0.073°	0.13 Tmm
	↻ y	≈ 0	0.073°	0
	↻ z	≈ 0	0.073°	0
	→ z	0.022 Tmm / 0.1 mm	30 μm 1)	0.16 Tmm
	→ y	0.022 Tmm / 0.1 mm	20 μm 2)	0.10 Tmm

1) slit error

2) gap error

3) field error of single block scaled with $\sqrt{560}$

4) including magnet block tolerances : □ 30 μm
 ⊥ 50 μm
 // 50 μm

➤ field integral errors based on geometrical tolerances are expected to be not larger than 0.25 Tmm

Straightness of Magnetic Structure

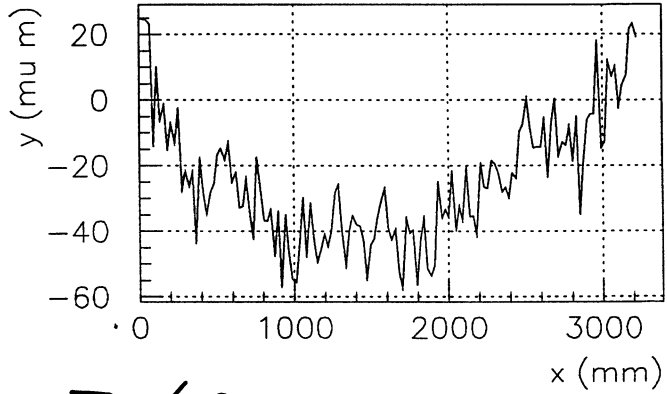
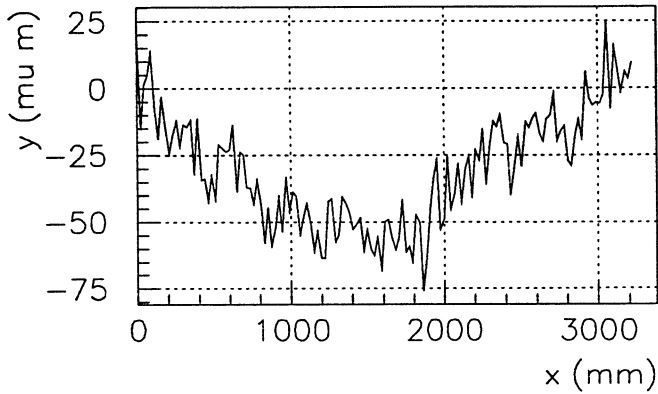
left row

upper I-beam

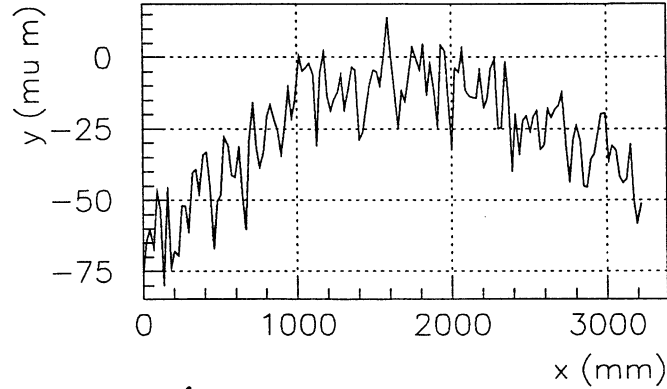
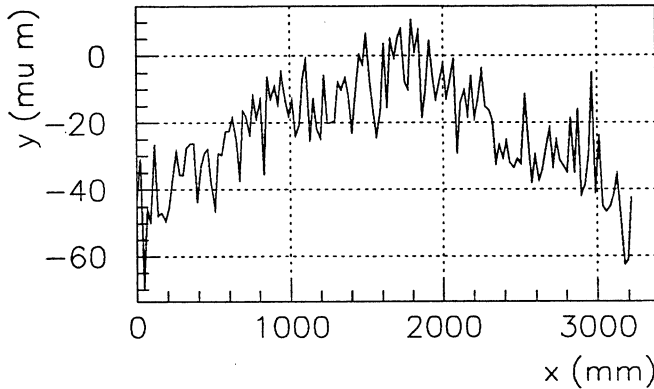
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right row

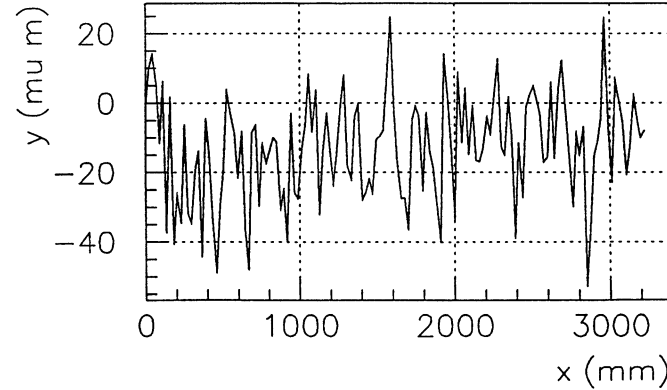
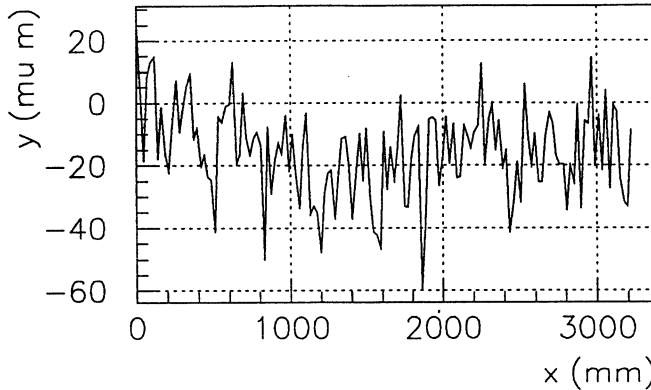
Straightness of I-Beams Including Magnets



lower I-beam

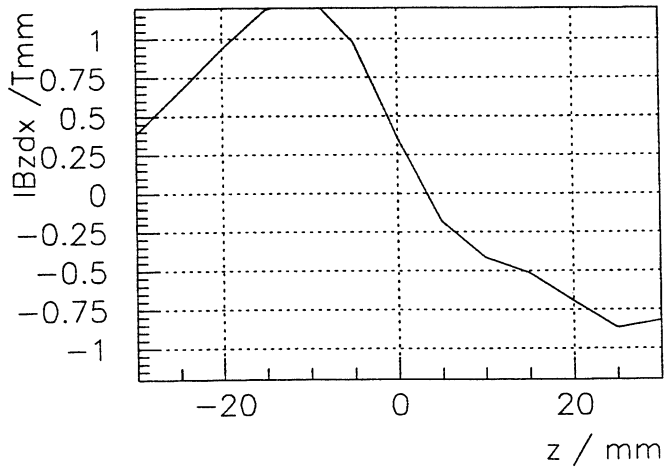
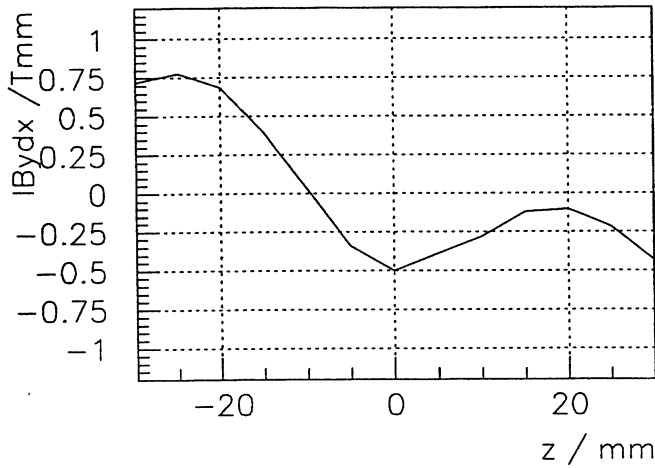
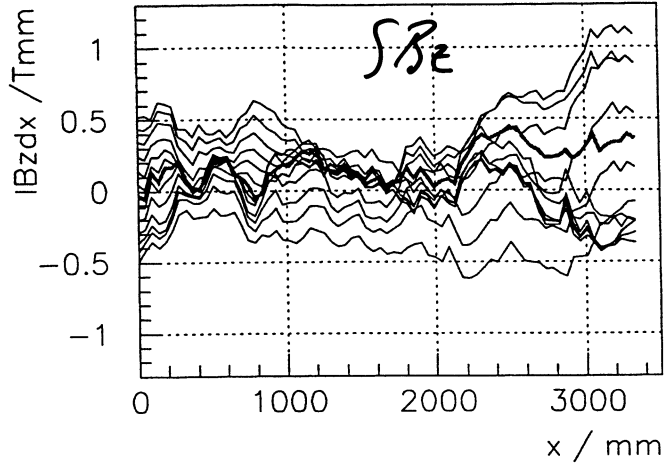
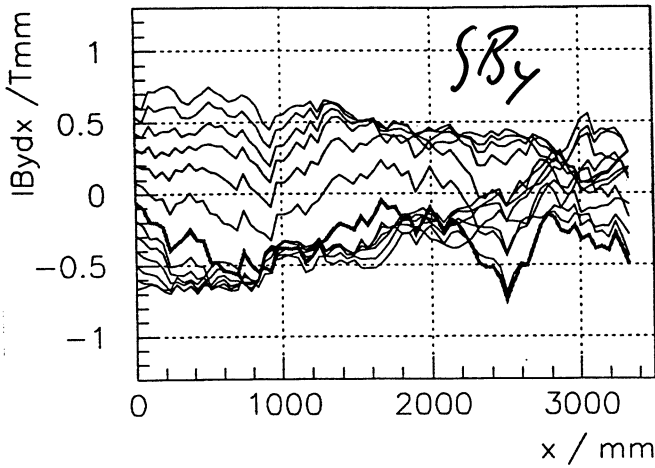


gap variation



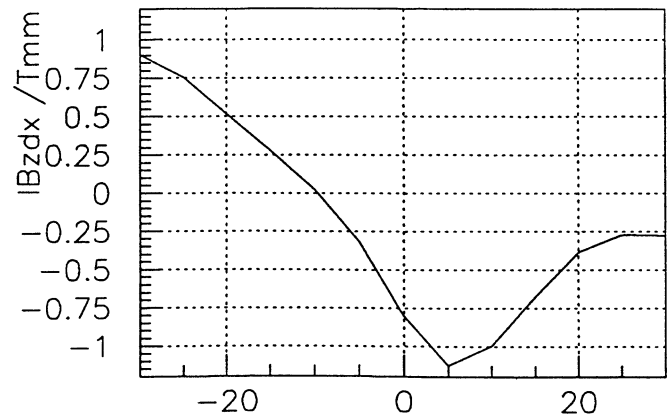
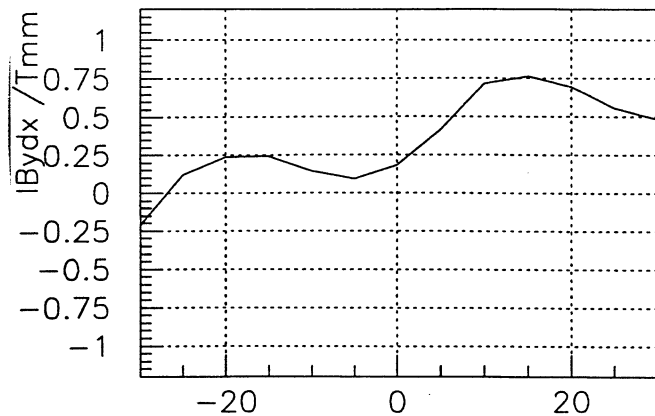
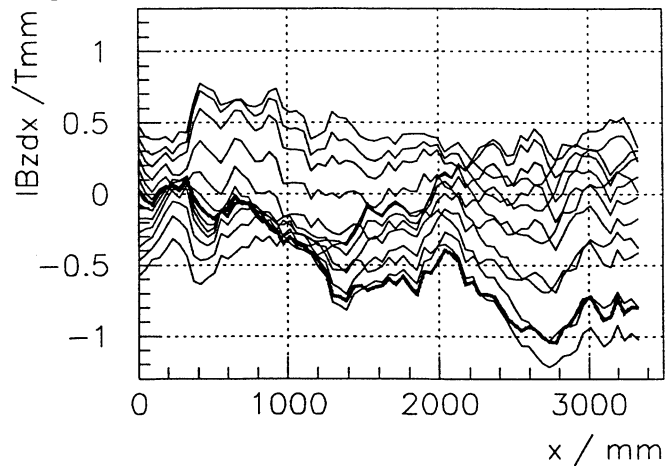
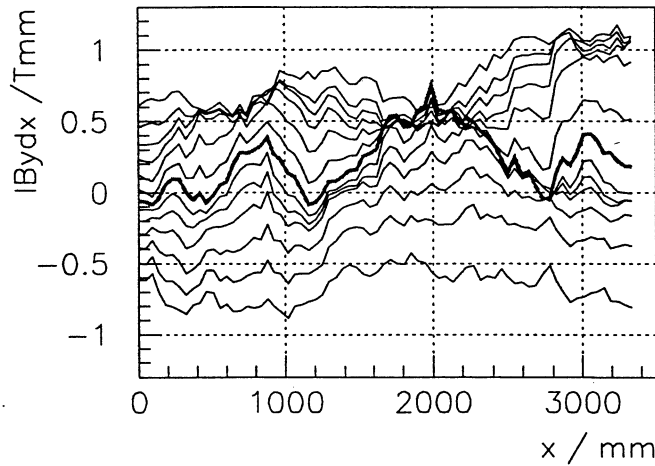
1st Field Integrals, Unsorted

Rows OV + UH, Predict from Single Block Measurements, Unsorted



upper I-beam

Rows UV + OH, Predict from Single Block Measurements, Unsorted

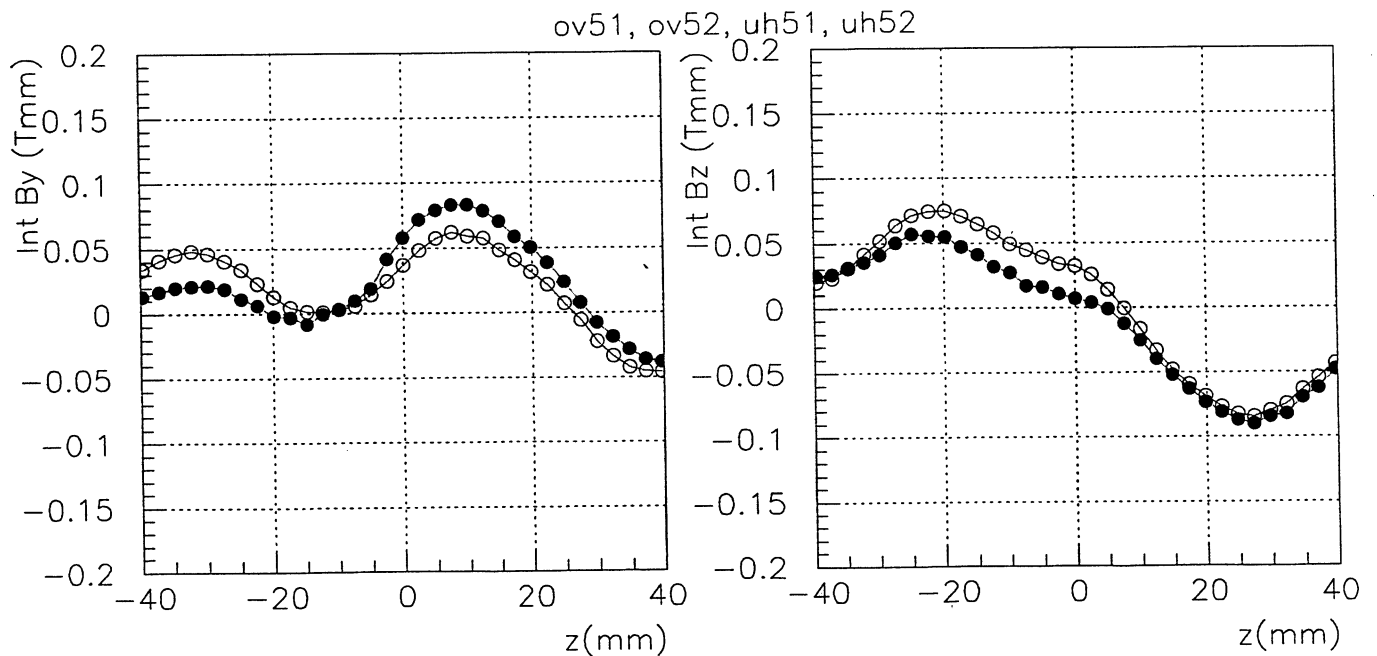
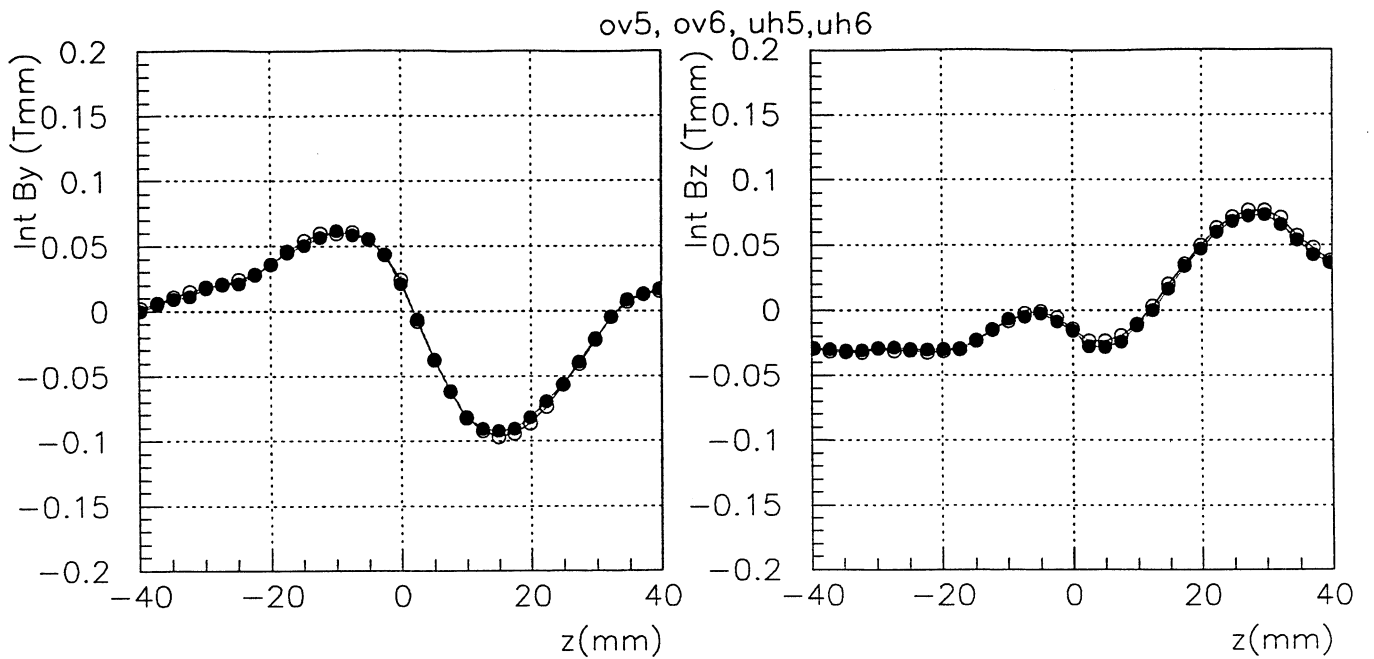


lower I-beam

Comparison of Single Block and Magnet Pair Measurements

black circles: sum of field integrals of 8 single magnet blocks

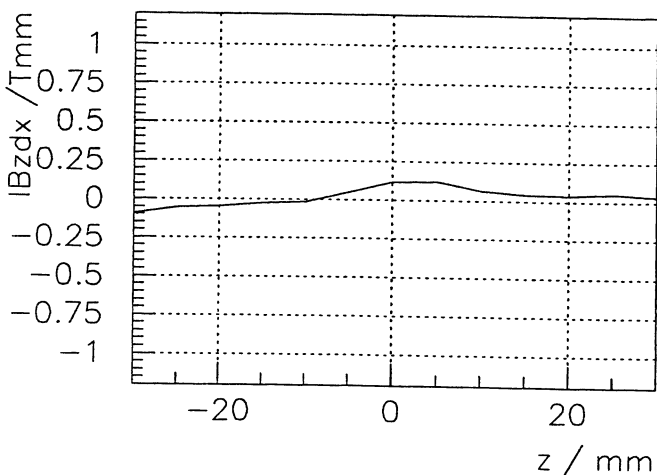
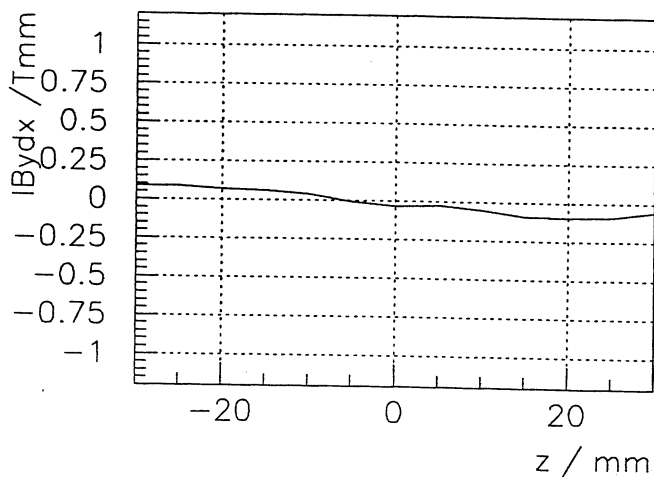
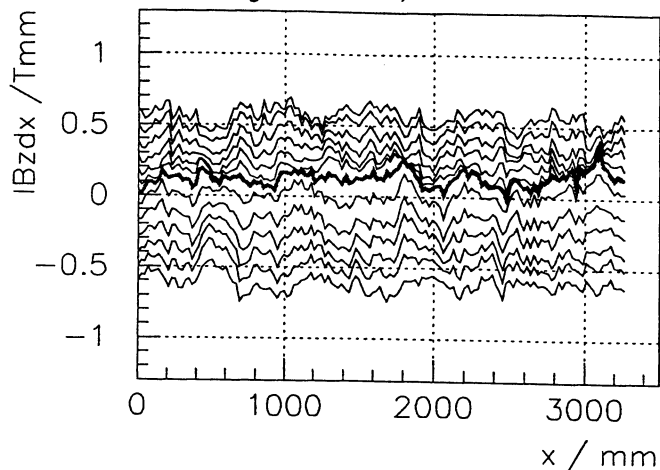
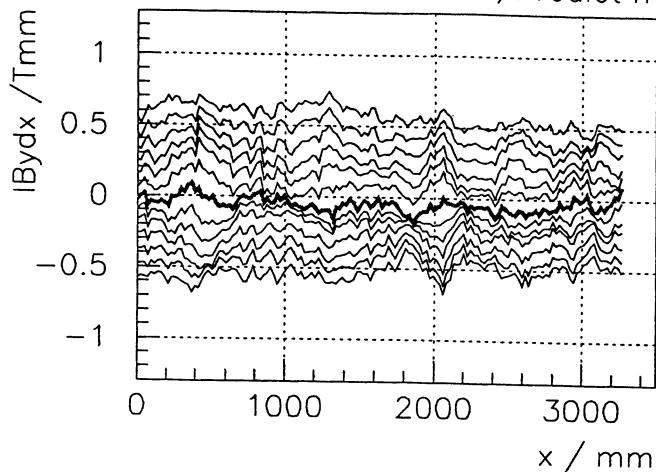
open circles: sum of field integrals of 4 magnet pairs (glued units)



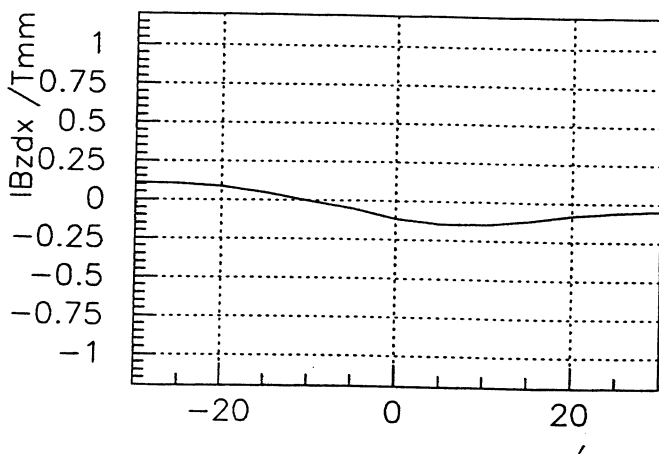
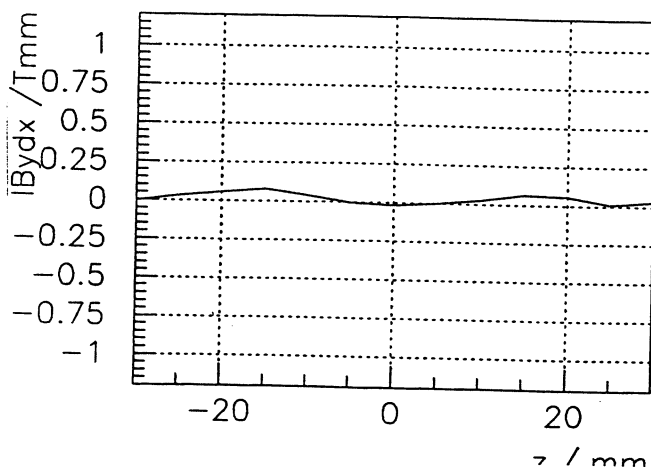
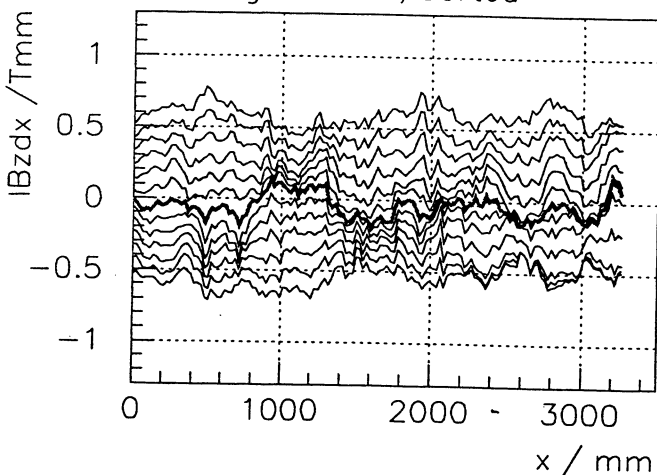
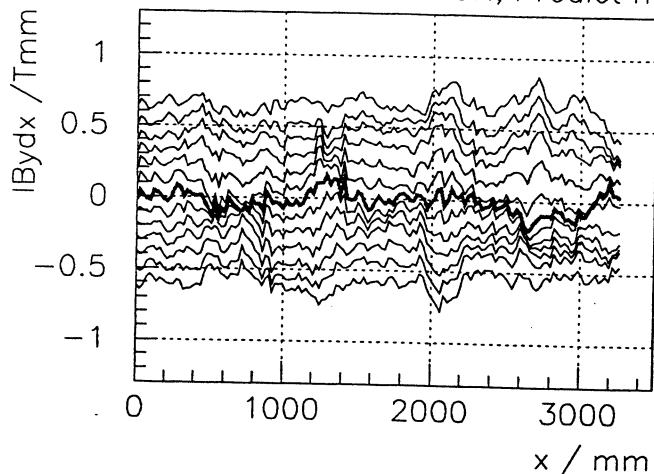
The comparison is a test for:

- bookkeeping of magnet blocks
- measurement accuracy (positioning accuracy)
- glueing errors, glueing tolerances
- sorting algorithm

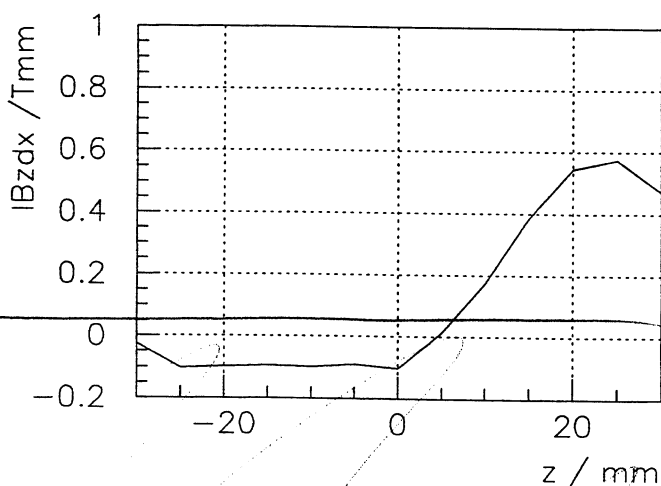
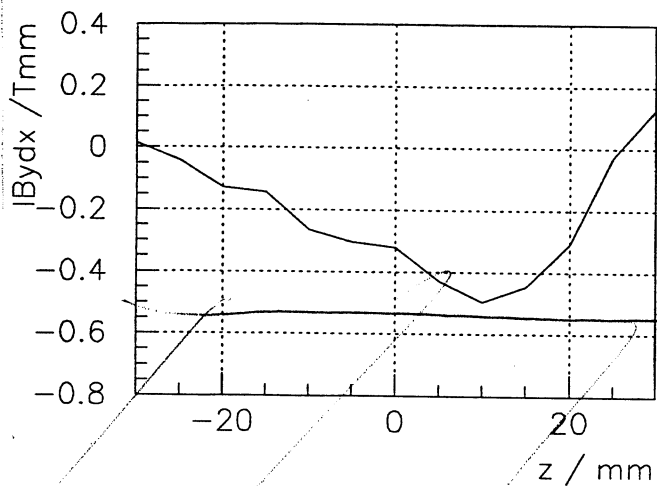
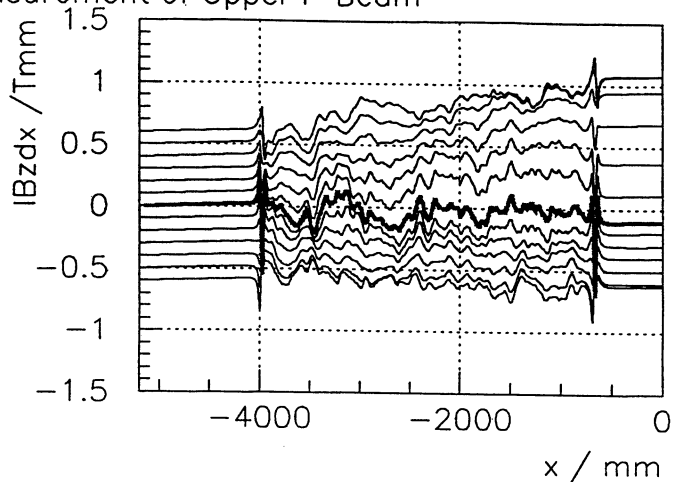
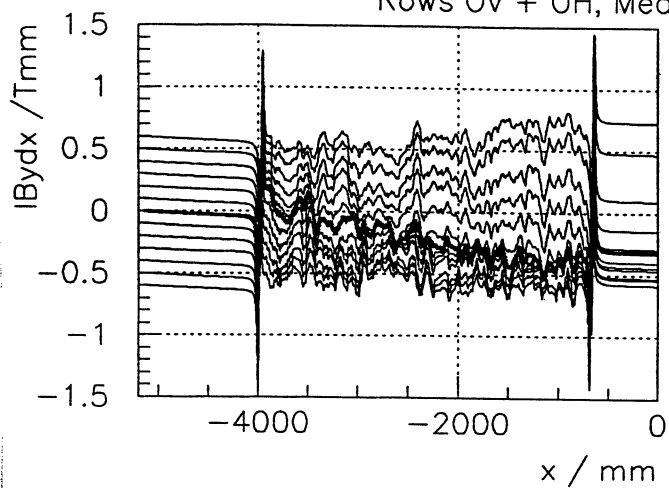
Rows OV + UH, Predict from Measured Magnet Pairs, Sorted



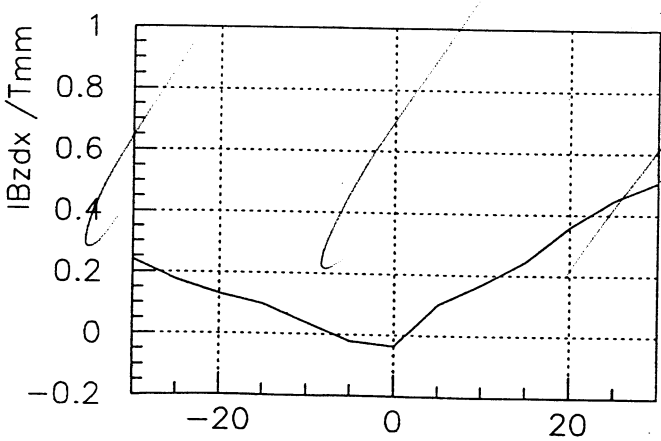
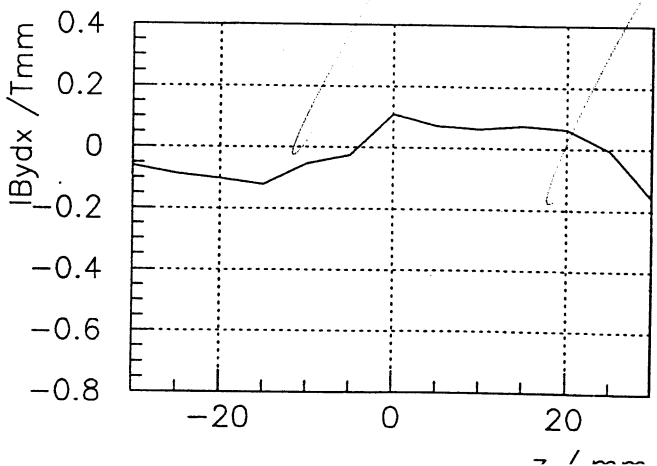
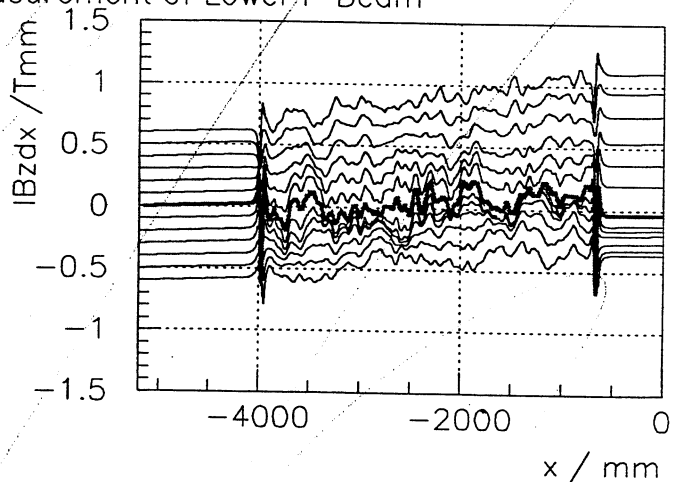
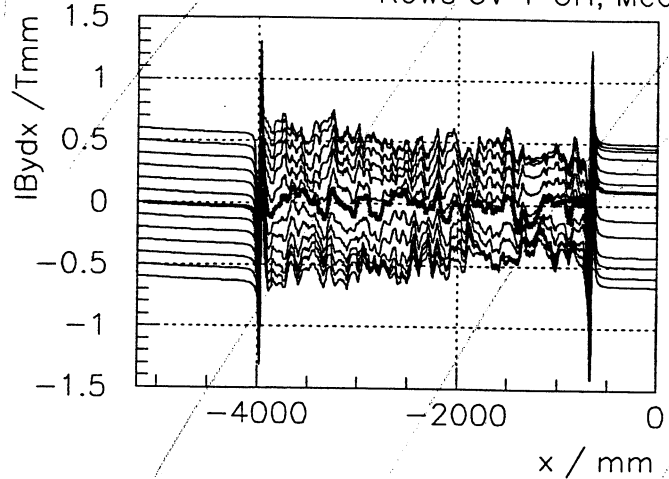
Rows UV + OH, Predict from Measured Magnet Pairs, Sorted



Rows OV + OH, Measurement of Upper I-Beam



Rows UV + UH, Measurement of Lower I-Beam

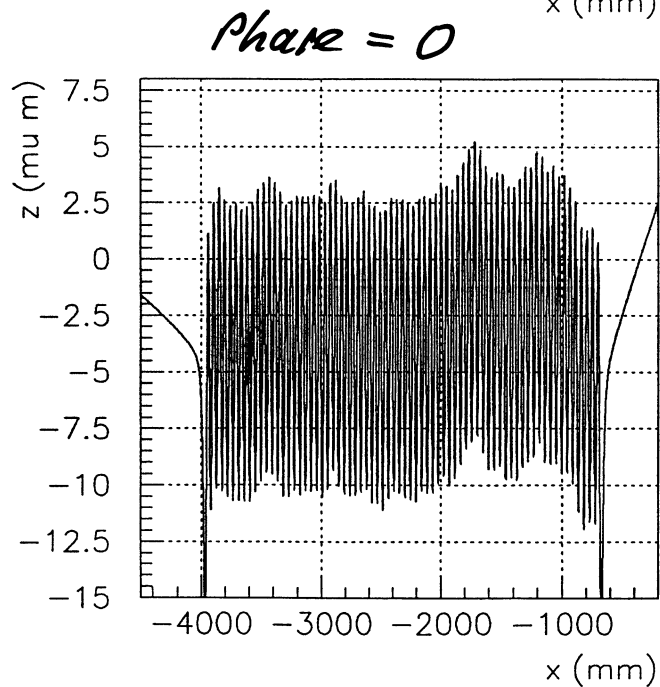
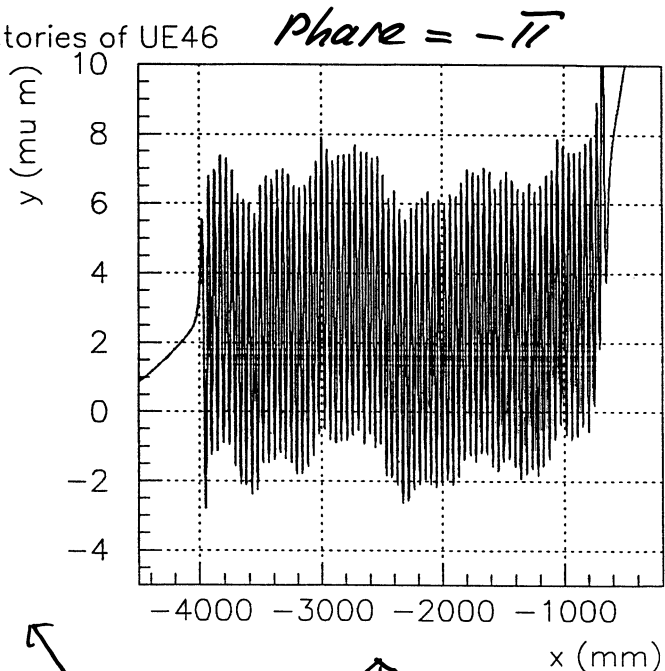
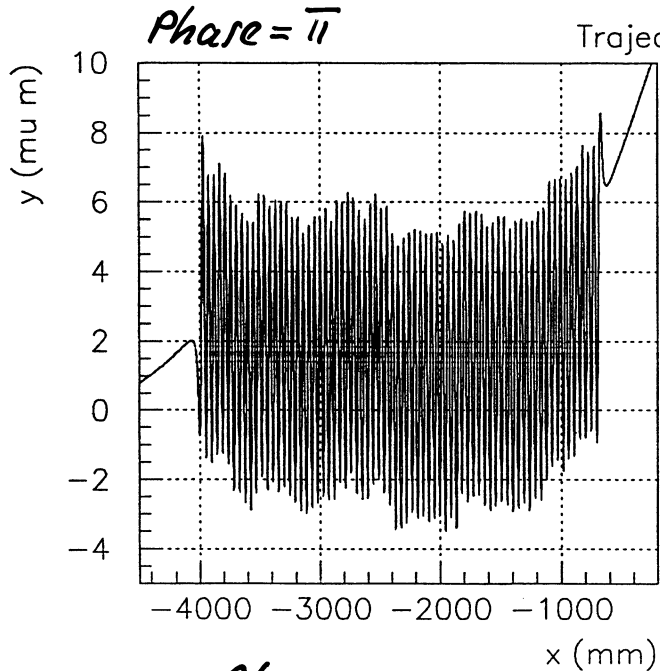


UE46 APPLE Undulator

$\lambda = 46 \text{ mm}$, 70 periods
 $S_{op} = 16 \text{ mm}$

(preliminary results, ends not yet compensated)

2001/10/01 15.28



$\Delta\phi = 3,1^\circ$
 $\Delta\phi = 3,3^\circ$
 $\Delta\phi = 3,5^\circ$

Future Developments **(essential for large scale undulator production)**

Improvement of magnet block quality is desirable

In the meantime:

- complete characterization of the magnets
including inhomogeneities

 - improvement of positioning accuracy for measurements

 - reduction of measurement time per unit

 - measurement of subassemblies instead of single blocks

- development of technologies for magnet assembly
which are fast and precise to allow for a good prediction
of field quality

- reduction of time for final shimming at granite bench
by careful block characterization, sorting and precise
assembly of magnetic structure